

# **TEST REPORT**

Report No.:	8233EU012316W		
Applicant:	SHENZHEN ELECTRON TECHNOLOGY CO., LTD.		
Address:	Bld.2, Yingfeng Industrial Zone, Tantou Community, Songgang Street, Bao'an, Shenzhen, China		
Product Name:	Android Tablet		
Model No.:	WF2489T (refer to clause 2.4)		
Trademark:	N/A		
FCC ID:	2ABC5-E0082		
Test Standard(s):	47 CFR Part 15 Subpart C		
Date of Receipt:	Sep. 23, 2024		
Test Date:	Sep. 23, 2024 – Oct. 28, 2024		
Date of Issue:	Dec. 02, 2024		

ISSUED BY: SHENZHEN EU TESTING LABORATORY LIMITED

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# **Revision Record**

Report Version	Issued Date	Description	Status
V0	Dec. 02, 2024	Original	Valid



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# **Table of Contents**

1	COVER PAGE1		
2	GEN	ERAL INFORMATION	. 4
	2.1 2.2 2.3 2.4 2.5	APPLICANT INFORMATION MANUFACTURER INFORMATION FACTORY INFORMATION GENERAL DESCRIPTION OF E.U.T. TECHNICAL INFORMATION OF E.U.T.	4 4 4
3	TEST	SUMMARY	. 6
	3.1 3.2 3.3	TEST STANDARD TEST VERDICT TEST LABORATORY	. 6
4	TEST	CONFIGURATION	. 7
	4.1 4.2 4.3 4.4 4.5 4.6 4.7 4.8	TEST ENVIRONMENT TEST EQUIPMENT DESCRIPTION OF SUPPORT UNIT TEST MODE DESCRIPTION OF CALCULATION MEASUREMENT UNCERTAINTY DEVIATION FROM STANDARDS ABNORMALITIES FROM STANDARD CONDITION	7 8 8 9 9
5	TEST	TITEMS	10
	5.1	ANTENNA REQUIREMENT.         5.1.1       Test Requirement.         5.1.2       Antenna Anti-Replacement Construction.         5.1.3       Antenna Gain .	10 10
	5.2	CONDUCTED EMISSION AT AC POWER LINE	
		5.2.1       Test Requirement	11 11
	5.3	EMISSIONS BANDWIDTH	16
		<ul> <li>5.3.1 Test Requirement.</li> <li>5.3.2 Test Setup Diagram</li> <li>5.3.3 Test Procedure.</li> <li>5.3.4 Test Data.</li> </ul>	16 17
	5.4	FIELD STRENGTH OF FUNDAMENTAL EMISSIONS AND RADIATED EMISSION	
		5.4.1       Test Requirement.         5.4.2       Test Setup Diagram         5.4.3       Test Procedure.         5.4.4       Test Data	20 21 21
	5.5	FREQUENCY STABILITY	
		5.5.1Test Requirement	30 31
		TEST SETUP PHOTOS	
ANNE		EXTERNAL PHOTOS	

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# 2 General Information

# 2.1 Applicant Information

Applicant	SHENZHEN ELECTRON TECHNOLOGY CO., LTD.	
Address	Bld.2, Yingfeng Industrial Zone, Tantou Community, Songgang Street, Bao'an, Shenzhen, China	

# 2.2 Manufacturer Information

Manufacturer	SHENZHEN ELECTRON TECHNOLOGY CO., LTD.		
Address	Bld.2, Yingfeng Industrial Zone, Tantou Community, Songgang Street, Bao'an, Shenzhen, China		

# 2.3 Factory Information

Factory	SHENZHEN ELECTRON TECHNOLOGY CO., LTD.		
Address	Bld.2, Yingfeng Industrial Zone, Tantou Community, Songgang Street, Bao'an, Shenzhen, China		

# 2.4 General Description of E.U.T.

Product Name	Android Tablet		
Model No. Under Test	WF2489T		
List Model No.	FA2489T		
Description of Model differentiation	All models are same with electrical parameters and internal circuit structure, but only differ in appearance materials, colors and model name. (this information provided by the customer)		
Rating(s)	Adapter power supply: 12.0V-5.0A(Adapter input: 100-240V~, 50/60Hz, 1.5A; Output: 12.0V-5.0A 60W)		
Adapter 1	Model No.: FJ-SW729C1205000U Input: 100-240V~ 50/60Hz 1.5A Max Output: 12.0V <sup></sup> 5.0A, 60.0W Manufacturer: HUIZHOU FUJIA APPLIANCE TECH. CO., LTD.		
Adapter 2	Model No.: S065-1A120500B3 Input: 100-240V~ 50/60Hz 1.5A Output: 12.0V== 5.0A, 60.0W Manufacturer: Mass Power Electronic Limited		
Product Type	Mobile Portable Fix Location		
Test Sample No.	-1/2(Normal Sample), -2/2(Engineering Sample)		
Hardware Version	R141-V1.0A		
Software Version	N/A		
Remark	<ol> <li>The above information are declared by the applicant, EU-LAB is not responsible for the information accuracy provided by the applicant.</li> <li>For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.</li> </ol>		

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# 2.5 Technical Information of E.U.T.

Network and Wireless Connectivity	NFC
--------------------------------------	-----

The requirement for the following technical information of the EUT was tested in this report:

Technology	NFC
Operating Frequency	13.56MHz
Modulation Type	ASK
Antenna Type	FPC Antenna
Antenna Gain(Peak)	0 dBi
Remark The above information are declared by the applicant, EU-LAB is not responsible the information accuracy provided by the applicant.	



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# 3 Test Summary

# 3.1 Test Standard

The tests were performed according to following standards:

No.	Identity	Document Title
1	47 CFR Part 15, Subpart C	Intentional radiators of radio frequency equipment
2	ANSI C63.10-2020	American National Standard for Testing Unlicensed Wireless Devices

Remark:

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product maybe which result in lowering the emission/immunity should be checked to ensure compliance has been maintained.

3.2	<b>Test Verdict</b>	
-----	---------------------	--

No.	Description	FCC Part No.	Verdict	Remark
1	Antenna Requirement	15.203	Pass	
2	Conducted Emission at AC Power Line	15.207	Pass	
3	Emissions Bandwidth	15.215	Pass	
4	Field Strength of Fundamental Emissions	15.225(a)(b)(c)	Pass	
5	Radiated Emissions	15.225(d) / 15.209	Pass	
6	Frequency Stability	15.225(e)	Pass	

# 3.3 Test Laboratory

Test Laboratory	Shenzhen EU Testing Laboratory Limited		
Address	101, Building B1, Fuqiao Fourth Area, Qiaotou Community, Fuhai Subdistrict, Baoan District, Shenzhen, Guangdong, China		
Designation Number	CN1368		
Test Firm Registration Number	952583		

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# 4 Test Configuration

# 4.1 Test Environment

During the measurement, the normal environmental conditions were within the listed ranges:

Relative Humidity	30% to 60%		
Atmospheric Pressure	86 kPa to 106 kPa		
Temperature	NT (Normal Temperature)	+15℃ to +35℃	
Working Voltage of the EUT	NV (Normal Voltage)	120V, 60Hz for adapter	

# 4.2 Test Equipment

Conducted Emission at AC power line					
Equipment	Manufacturer	Model No	Serial No	Cal Date	Cal Due Date
L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	EE-004	2024/01/09	2025/01/08
EMI Test Receiver	Rohde & Schwarz	ESCI	EE-005	2024/01/09	2025/01/08
Test Software	Farad	EZ-EMC	EE-014	N.C.R	N.C.R

Radiated Emission and	Radiated Emission and RF Test					
Equipment	Manufacturer	Model No	Serial No	Cal Date	Cal Due Date	
EMI Test Receiver	ROHDE & SCHWARZ	ESPI	EE-006	2024/01/09	2025/01/08	
Bilog Broadband Antenna	SCHWARZBECK	VULB 9163	EE-007	2023/01/14	2026/01/13	
Double Ridged Horn Antenna	A-INFOMW	LB-10180-NF	EE-008	2023/01/12	2026/01/11	
Pre-amplifier	Agilent	8447D	EE-009	2024/01/09	2025/01/08	
Pre-amplifier	Agilent	8449B	EE-010	2024/01/09	2025/01/08	
MXA Signal Analyzer	Agilent	N9020A	EE-011	2024/01/09	2025/01/08	
MXG RF Vector Signal Generator	Agilent	N5182A	EE-012	2024/01/09	2025/01/08	
Test Software	Farad	EZ-EMC	EE-015	N.C.R	N.C.R	
MIMO Power Measurement Module	TSTPASS	TSPS 2023R	EE-016	2024/05/16	2025/05/15	
RF Test Software	TSTPASS	TS32893 V2.0	EE-017	N.C.R	N.C.R	
Wideband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	EE-402	2024/02/15	2025/02/14	
Loop Antenna	TESEQ	HLA6121	EE-403	2024/02/15	2025/02/14	
MXG RF Analog Signal Generator	Agilent	N5181A	EE-406	2024/02/15	2025/02/14	
Constant Temperature Humidity Chamber	Guangxin	GXP-401	ES-002	2024/07/30	2025/07/29	

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### 4.3 Description of Support Unit

No.	Title	Manufacturer	Model No.	Serial No.
1	Adapter	See section 2.4	N/A	N/A

#### 4.4 Test Mode

No.	Test Modes	Description
TM1 TX-13.56M-ASK		Keep the EUT connect to AC power line and works in continuously
		13.56 MHz transmitting in ASK modulation mode.

# 4.5 Description of Calculation

### 4.5.1. Field Strength Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor and subtracting the Amplifier Gain and Duty Cycle Correction Factor (if any) from the measured reading. The basic equation with a sample calculation is as follows:

#### FS (dBuV/m) = RA (dBuV) + AF (dB/m) + CL (dB) - AG (dB)

Where FS = Field Strength	CL = Cable Attenuation Factor (Cable Loss)
RA = Reading Amplitude	AG = Amplifier Gain
AF = Antenna Factor	

#### 4.5.2. Disturbance Calculation

The AC mains conducted disturbance is calculated by adding the 10dB Pulse Limiter and Cable Factor and Duty Cycle Correction Factor (if any) from the measured reading. The basic equation with a sample calculation is as follows:

#### CD (dBuV) = RA (dBuV) + PL (dB) + CL (dB)

Where CD = Conducted Disturbance	CL = Cable Attenuation Factor (Cable Loss)
RA = Reading Amplitude	PL = 10 dB Pulse Limiter Factor

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### 4.6 Measurement Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2.

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Test Item	Measurement Uncertainty	
Conducted Emission	2.64 dB	
Occupied Channel Bandwidth	2.8 %	
RF output power, conducted	0.68 dB	
Power Spectral Density, conducted	1.37 dB	
Unwanted Emissions, conducted	1.84 dB	
Radiated Emission (9kHz- 30MHz)	Ur = 2.50 dB	
Radiated Emission	Ur = 2.70 dB (Horizontal)	
(30MHz- 1GHz)	Ur = 2.70 dB (Vertical)	
Radiated Emission	Ur = 3.50 dB (Horizontal)	
(1GHz- 18GHz)	Ur = 3.50 dB (Vertical)	
Radiated Emission	Ur = 5.15 dB (Horizontal)	
(18GHz- 40GHz)	Ur = 5.24 dB (Vertical)	
Temperature	0.8°C	
Humidity	4%	

# 4.7 Deviation from Standards

None.

# 4.8 Abnormalities from Standard Condition

None.

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# 5 Test Items

# 5.1 Antenna requirement

### 5.1.1 Test Requirement

### 5.1.2 Antenna Anti-Replacement Construction

The Antenna Anti-Replacement as following method:

Protected Method	Description
The antenna is embedded in the product.	The EUT has a permanently and irreplaceable inductive loop antenna.

### 5.1.3 Antenna Gain

The antenna peak gain of EUT is less than 6 dBi.

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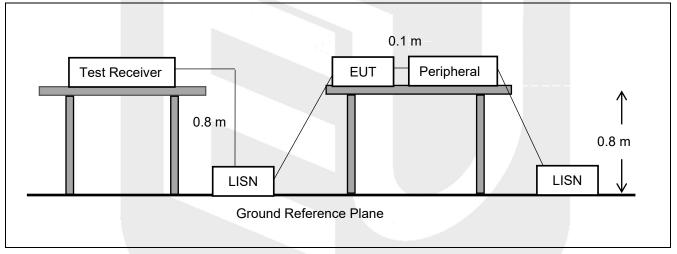


# 5.2 Conducted Emission at AC Power Line

#### 5.2.1 Test Requirement

Test Requirement:	Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 $\mu$ H/50 ohms line impedance stabilization network (LISN).		
Test Limit	Frequency of emission (MHz) 0.15-0.5 0.5-5 5-30 *Decreases with the logarithm of the	Conducted limit (dBµV) Quasi-peak 66 to 56* 56 60	Average           56 to 46*           46           50
Test Method	Refer to ANSI C63.10-2020 section 6.2, standard test method for ac power-line conducted emissions from unlicensed wireless devices.		

#### 5.2.2 Test Setup Diagram



### 5.2.3 Test Procedure

The EUT is put on the plane 0.8 m high above the ground by insulating support and connected to the AC mains through Line Impedance Stability Network (L.I.S.N). This provided a 50ohm coupling impedance for the tested equipment. Both sides of AC line are investigated to find out the maximum conducted emission according to the test standard regulations during conducted emission measurement.

The bandwidth of the field strength meter (R&S Test Receiver ESCI) is set at 9kHz in 150kHz~30MHz. The maximum conducted interference is searched using Peak (PK), if the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. Refer to recorded points and plots below.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

### 5.2.4 Test Data

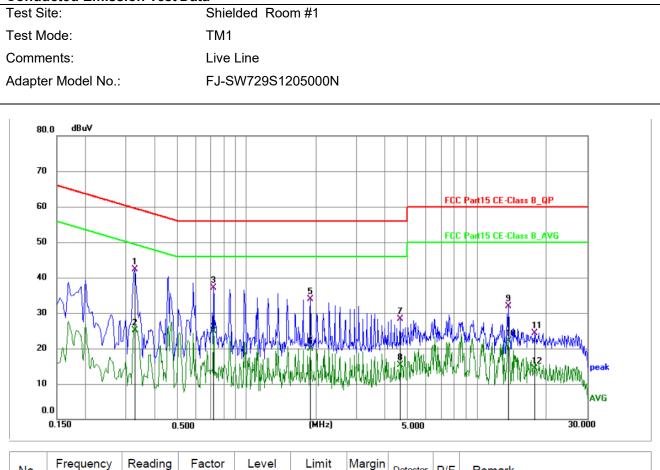
PASS.

Only the worst case data was showed in the report, please to see the following pages.

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#### Conducted Emission Test Data

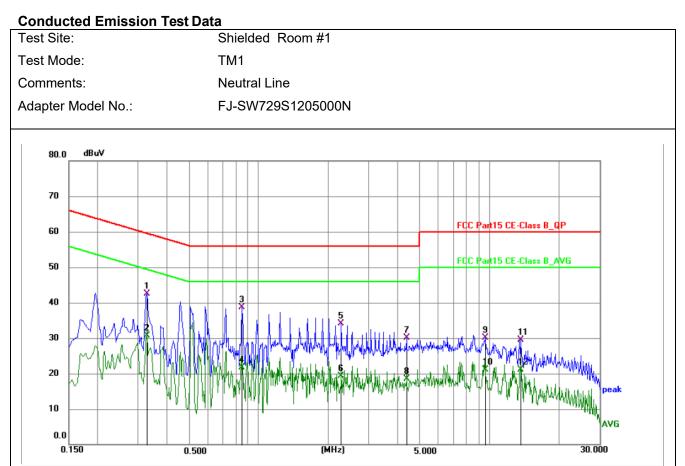


No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1 *	0.3255	32.36	9.99	42.35	59.57	-17.22	QP	Ρ	
2	0.3255	15.14	9.99	25.13	49.57	-24.44	AVG	Р	
3	0.7170	27.11	10.04	37.15	56.00	-18.85	QP	Р	
4	0.7170	14.83	10.04	24.87	46.00	-21.13	AVG	Р	
5	1.8915	23.95	10.02	33.97	56.00	-22.03	QP	Ρ	
6	1.8915	9.86	10.02	19.88	46.00	-26.12	AVG	Р	
7	4.6320	18.27	10.04	28.31	56.00	-27.69	QP	Р	
8	4.6320	5.26	10.04	15.30	46.00	-30.70	AVG	Р	
9	13.6230	22.01	9.97	31.98	60.00	-28.02	QP	Ρ	
10	13.6230	12.12	9.97	22.09	50.00	-27.91	AVG	Р	
11	17.7360	14.26	10.02	24.28	60.00	-35.72	QP	Р	
12	17.7360	4.32	10.02	14.34	50.00	-35.66	AVG	Р	
Note:	Note: Level = Reading + Factor Margin = Level – Limit								

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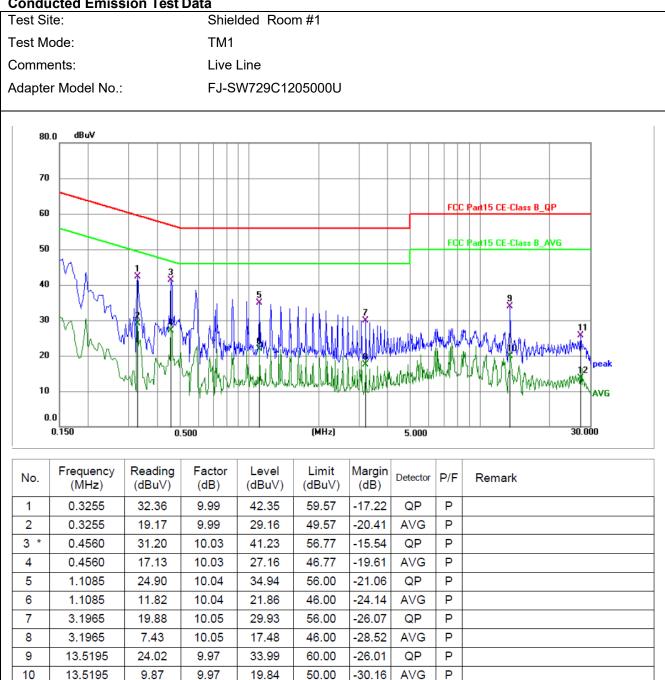
No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1 *	0.3255	32.43	10.02	42.45	59.57	-17.12	QP	Ρ	
2	0.3255	20.73	10.02	30.75	49.57	-18.82	AVG	Р	
3	0.8475	28.54	10.07	38.61	56.00	-17.39	QP	Р	
4	0.8475	11.70	10.07	21.77	46.00	-24.23	AVG	Р	
5	2.2830	24.13	10.06	34.19	56.00	-21.81	QP	Р	
6	2.2830	9.26	10.06	19.32	46.00	-26.68	AVG	Р	
7	4.3710	20.09	10.05	30.14	56.00	-25.86	QP	Р	
8	4.3710	8.45	10.05	18.50	46.00	-27.50	AVG	Р	
9	9.6225	20.17	10.01	30.18	60.00	-29.82	QP	Р	
10	9.6225	11.00	10.01	21.01	50.00	-28.99	AVG	Р	
11	13.6590	19.45	10.00	29.45	60.00	-30.55	QP	Р	
12	13.6590	11.16	10.00	21.16	50.00	-28.84	AVG	Ρ	
Note:	lote: Level = Reading + Factor Margin = Level – Limit								

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#### **Conducted Emission Test Data**



Note: Level = Reading + Factor

15.58

3.56

10.22

10.22

25.80

13.78

27.3525

27.3525

11 12

Margin = Level – Limit

60.00

50.00

-34.20

-36.22

QP

AVG

Ρ

Ρ

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6

7

8 9

10

11

12

1.5000

4.3935

4.3935

12.7590

12.7590

26.7360

26.7360

Note: Level = Reading + Factor

13.34

19.04

8.18

18.19

8.51

14.31

3.18

10.06

10.05

10.05

10.00

10.00

10.19

10.19

23.40

29.09

18.23

28.19

18.51

24.50

13.37

46.00

56.00

46.00

60.00

50.00

60.00

50.00

Margin = Level – Limit

-22.60

-26.91

-27.77

-31.81

-31.49

-35.50

-36.63

AVG

QP

AVG

QP

AVG

QP

AVG

Ρ

Ρ

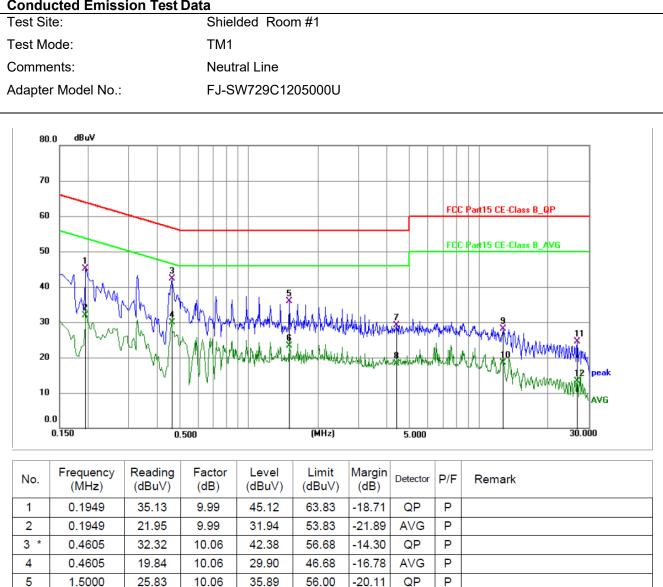
Ρ

Ρ

Ρ Ρ

Ρ

#### **Conducted Emission Test Data**



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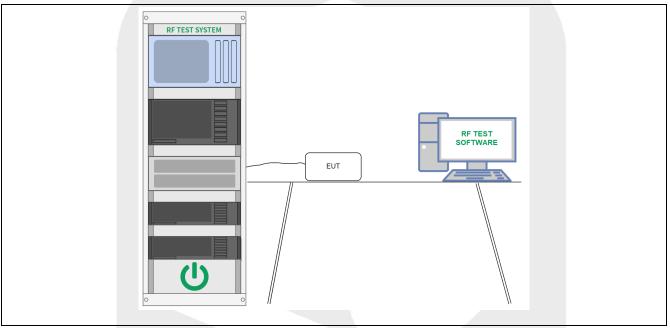


# 5.3 Emissions Bandwidth

#### 5.3.1 Test Requirement

Test Requirement	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Method	ANSI C63.10-2020, section 6.9.2 Occupied bandwidth—relative measurement procedure

#### 5.3.2 Test Setup Diagram



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#### 5.3.3 Test Procedure

a) The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the EMI receiver or spectrum analyzer shall be between two times and five times the OBW.
b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW, unless otherwise specified by the applicable requirement.

c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.5.2.

d) Steps a) through c) might require iteration to adjust within the specified tolerances.

e) The dynamic range of the instrument at the selected RBW shall be more than 10 dB below the target "-xx dB down" requirement; that is, if the requirement calls for measuring the −20 dB OBW, the instrument noise floor at the selected RBW shall be at least 30 dB below the

#### reference value.

f) Set detection mode to peak and trace mode to maxhold.

g) Determine the reference value: Set the EUT to transmit an unmodulated carrier or modulated signal, as applicable. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace (this is the reference value).

h) Determine the "-xx dB down amplitude" using [(reference value) -xx]. Alternatively, this calculation may be made by using the marker-delta function of the instrument.

i) If the reference value is determined by an unmodulated carrier, then turn the EUT modulation ON, and either clear the existing trace or start a new trace on the spectrum analyzer and allow the new trace to stabilize. Otherwise, the trace from step g) shall be used for step j).

j) Place two markers, one at the lowest frequency and the other at the highest frequency of the envelope of the spectral display, such that each marker is at or slightly below the "-xx dB down amplitude" determined in step h). If a marker is below this "-xx dB down amplitude" value, then it shall be as close as possible to this value. The occupied bandwidth is the frequency difference between the two markers. Alternatively, set a marker at the lowest frequency of the envelope of the spectral display, such that the marker is at or slightly below the "-xx dB down amplitude" determined in step h). Reset the marker-delta function and move the marker to the other side of the emission until the delta marker amplitude is at the same level as the reference marker amplitude. The marker-delta frequency reading at this point is the specified emission bandwidth.

k)The occupied bandwidth shall be reported by providing plot(s) of the measuring instrument display; the plot axes and the scale units per division shall be clearly labeled. Tabular data may be reported in addition to the plot(s).

# 5.3.4 Test Data

### PASS.

Please refer to the following pages.

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Frequency (MHz)	20dB bandwidth (KHz)	99% bandwidth (KHz)	Result	
13.56	26.93	22.881	Pass	

Test Plot

ef Value 20.00 dBm	Cente	ENSE:PULSE SOURCE OFF r Freq: 13.560000 MHz iree Run Avg Hol i: 10 dB	Radio S d:>10/10	PM Oct 15, 2024 td: None evice: BTS	Trace/Detector
) dB/div Ref 20.00 dBm					
0.0					Clear Writ
0.0					Avera
					Max Ho
enter 13.56 MHz Res BW 10 kHz	#	VBW 30 kHz	S  Sv	pan 80 kHz veep 1 ms	Min Ho
Occupied Bandwidth 22	.881 kHz	Total Power	-7.88 dBm		Detect
Transmit Freq Error	501 Hz	OBW Power	99.00 %		Average <u>Auto</u> M
x dB Bandwidth	26.93 kHz	x dB	-20.00 dB		

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# 5.4 Field Strength of Fundamental Emissions and Radiated Emission

### 5.4.1 Test Requirement

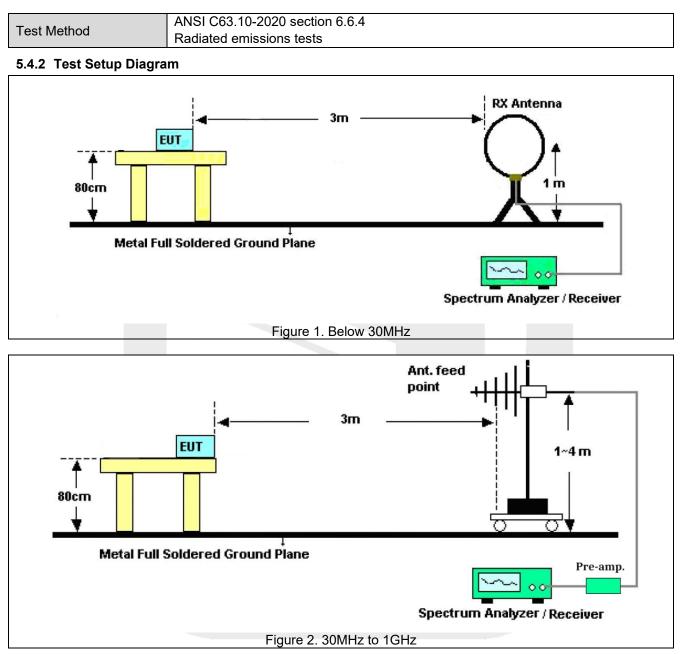
Test Requirement	FCC §15.225; FCC §15.209										
	According to FCC section 15.225, for <30 MHz, Radiated emissions were										
	measured according to ANSI C63.4. The EUT was set to transmit at the highest										
	output power. The EUT was set 10 meter away from the measuring antenna. The										
	loop antenna was positioned 1 meter above the ground from the center of the loop.										
		The measuring bandwidth was set to 10 kHz. (Note: During testing the receive									
	-	antenna was rotated about its axis to maximize the emission from the EUT) There was no detected Restricted bands and Radiated spurious emission below 30MHz. The 30m limit was converted to 3m Limit using square factor(x) as it was									
	30MHz. The 30m limit w										
		found by measurements as follows;									
	3 m Limit(dBµV/m) = 20	$3 \text{ m Limit}(dB\mu V/m) = 20\log(X)+40\log(30/3)=20\log(15848)+40\log(30/3)=124dB\mu V$									
		Except as provided elsewhere in this Subpart, the emissions from an intentional									
	radiator shall not exceed	the field streng	th levels specifie	d in the following table:							
	Frequency range	Field Stre	ength@30m	Field Strength@3m							
	(MHz)	μV/m	dBµV/m	dBµV/m							
	Below 13.110	30	29.5	69.5							
	13.110 ~ 13.410	106	40.5	80.5							
	13.410 ~ 13.553	334	50.5	90.5							
	13.553 ~13.567	15848	84	124							
	13.567 ~ 13.710	334	50.5	90.5							
	13.710 ~14.010			80.5							
	Above 14.010			69.5							
	NOTE:										
	1. Field Strength (dBµ∖	//m) = 20*log[Fie	eld Strength (µV/	m)].							
T	2. In the emission table	s above, the tigh	nter limit applies	at the band edges.							
Test Limit		FCC §15.225(d)									
				elsewhere in this subpart,							
			or shall not excee	ed the field strength levels							
	specified in the following										
	Frequency	Field str		Measurement distance							
	(MHz)	(microvolts		(meters)							
	0.009-0.490	2400/F(	(kHz)	300							
	0.490-1.705	24000/F	(kHz)	30							
	1.705-30.0	30		30							
	30-88	100	**	3							
	88-216	150 **		3							
	216-960	200	**	3							
	Above 960	500	)	3							
	** Except as provided in			-							
		radiators operating under this section shall not be located in the frequency bands									
	54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g.,										
	these frequency hands i	s nermitted unde	er other sections	of this part e d							
		s permitted unde	er other sections	of this part, e.g.,							
	§§ 15.231 and 15.241.	s permitted unde	er other sections	of this part, e.g.,							
	§§ 15.231 and 15.241. NOTE:										
	§§ 15.231 and 15.241.	V/m) = 20*log[F	ield Strength (μV	/m)].							

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Page 20 of 34



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#### 5.4.3 Test Procedure

The measurement frequency range is from 9 kHz to the 10th harmonic of the fundamental frequency. The Turn Table is actuated to turn from 0° to 360°, and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power.

The power of the EUT transmitting frequency should be ignored.

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW =1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as: RBW = 9KHz, VBW =30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as: RBW = 100kHz, VBW =300kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For above 1GHz,Set the spectrum analyzer as: RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple. RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

For measurement below 1GHz, If the emission level of the EUT measured by the peak detector is 3 dB lower than the applicable limit, the peak emission level will be reported, Otherwise, the emission measurement will be repeated using the quasi-peak detector and reported.

# 5.4.4 Test Data

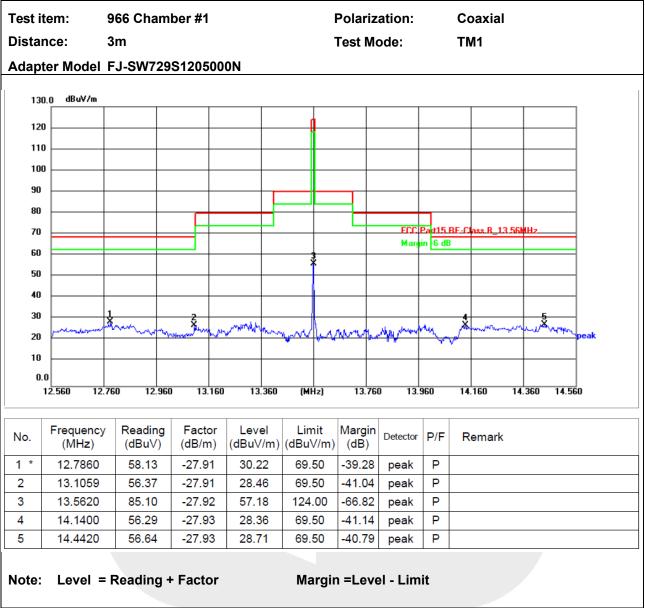
#### PASS.

During the test, pre-scan the all test, only the worst case is recorded in the report.

For RSE below 30MHz, all other test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.

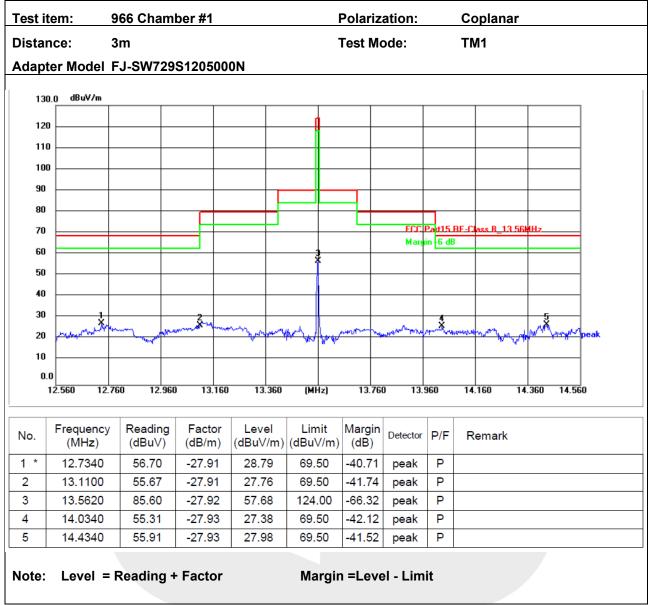
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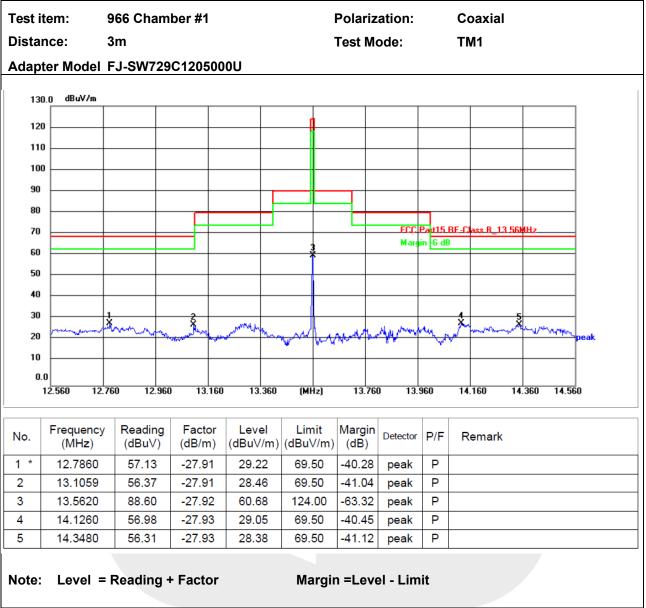
# SHENZHEN EU TESTING LABORATORY LIMITED





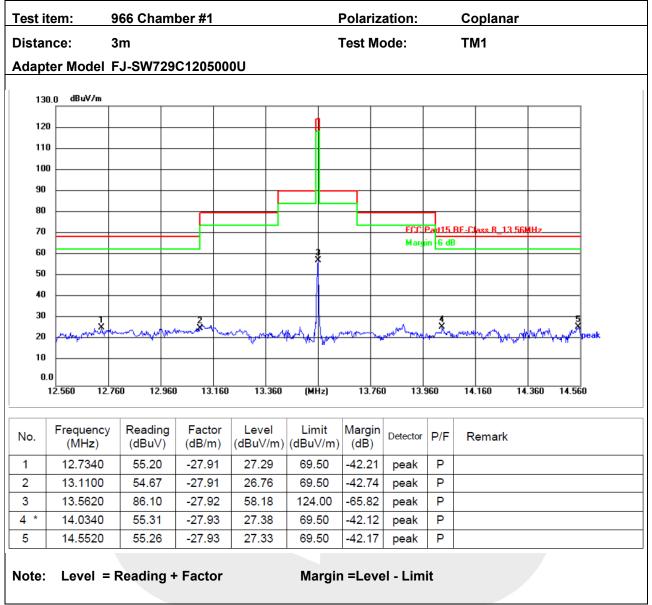
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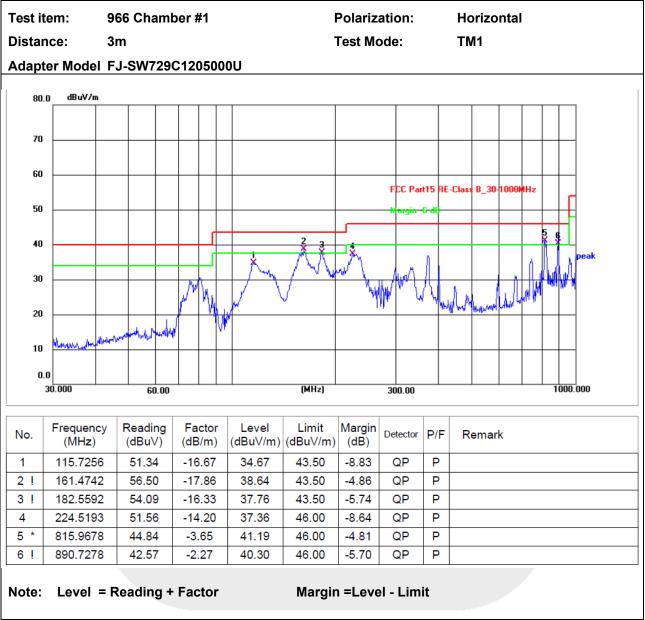
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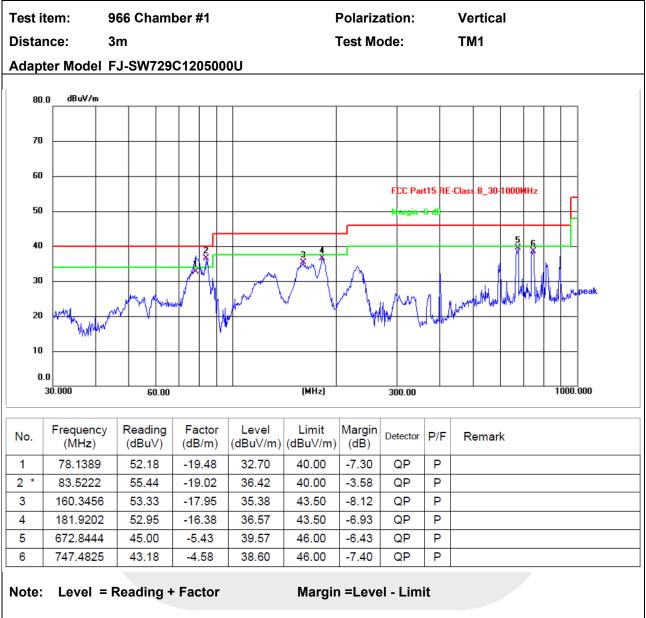
# SHENZHEN EU TESTING LABORATORY LIMITED





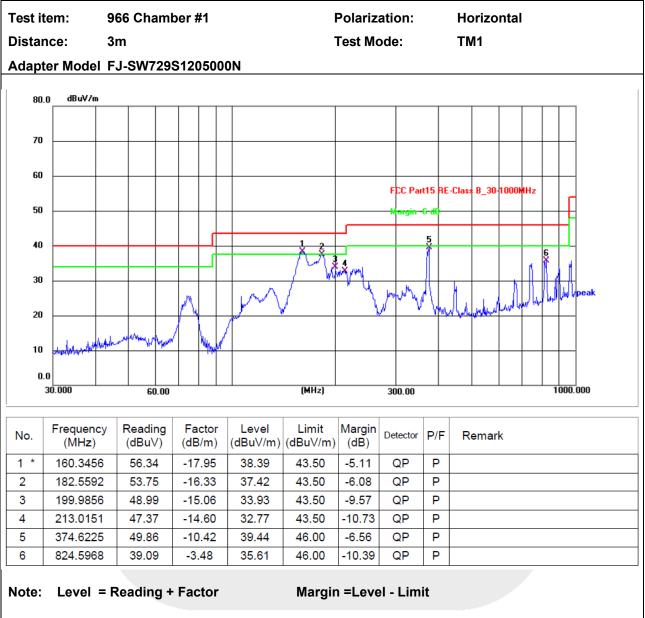
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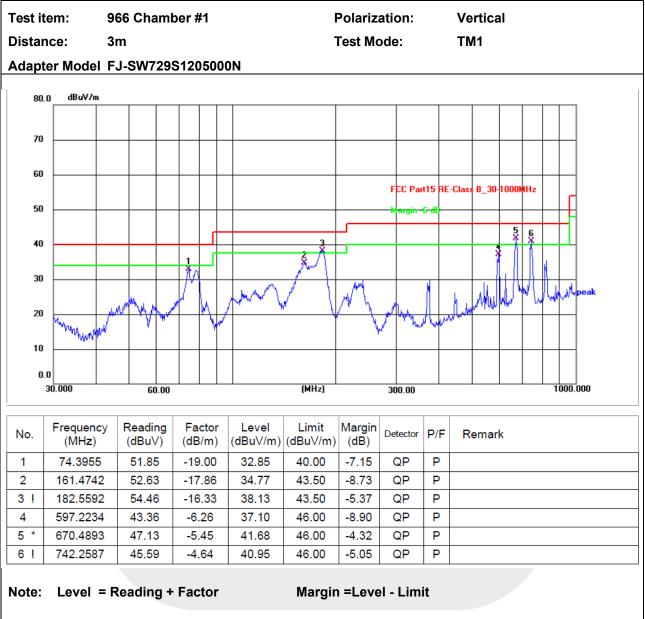




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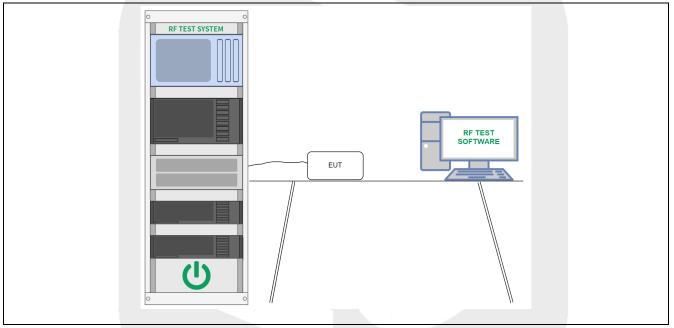


# 5.5 Frequency Stability

#### 5.5.1 Test Requirement

	FCC §15.225(e)
	The frequency tolerance of the carrier signal shall be maintained within ±0.01% of
	the operating frequency over a temperature variation of -20 degrees to +50
Test Requirement	degrees C at normal supply voltage, and for a variation in the primary supply
	voltage from 85% to 115% of the rated supply voltage at a temperature of 20
	degrees C. For battery operated equipment, the equipment tests shall be
	performed using a new battery.
Test Mathed	ANSI C63.10-2020, section 6.8
Test Method	Frequency Stability Test

### 5.5.2 Test Setup Diagram



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#### 5.5.3 Test Procedure

#### ♦ Frequency stability with respect to ambient temperature

a) Supply the EUT with a nominal ac voltage or install a new or fully charged battery in the EUT. If possible, a dummy load shall be connected to the EUT because an antenna near the metallic walls of an environmental test chamber could affect the output frequency of the EUT. If the EUT is equipped with a permanently attached, adjustable-length antenna, then the EUT shall be placed in the center of the chamber with the antenna adjusted to the shortest length possible. Turn ON the EUT and tune it to one of the number of frequencies.

b) Couple the unlicensed wireless device output to the measuring instrument by connecting an antenna to the measuring instrument with a suitable length of coaxial cable and placing the measuring antenna near the EUT (e.g., 15 cm away), or by connecting a dummy load to the measuring instrument through an attenuator if necessary.

NOTE-An instrument that has an adequate level of accuracy as specified by the procuring or regulatory agency is the recommended measuring instrument.

c) Adjust the location of the measurement antenna and the controls on the measurement instrument to obtain a suitable signal level (i.e., a level that will not overload the measurement instrument but is strong enough to allow measurement of the operating or fundamental frequency of the EUT).

d) Turn the EUT OFF and place it inside the environmental temperature chamber. For devices that have oscillator heaters energize only the heater circuit.

e) Set the temperature control on the chamber to the highest specified in the regulatory requirements for the type of device and allow the oscillator heater and the chamber temperature to stabilize.

f) While maintaining a constant temperature inside the environmental chamber, turn the EUT ON and record the operating frequency at startup, and at 2 min, 5 min, and 10 min after the EUT is energized. Four measurements in total are made.

g) Measure the frequency at each of frequencies.

h) Switch OFF the EUT but do not switch OFF the oscillator heater.

i) Lower the chamber temperature by not more than 10  $^{\circ}$ C, and allow the temperature inside the chamber to stabilize.

j) Repeat step f through step i) down to the lowest specified temperature.

### ♦ Frequency stability when varying supply voltage

Unless otherwise specified, these tests shall be made at ambient room temperature (+15 °C to +25 °C). a) An antenna shall be connected to the antenna output terminals of the EUT if possible. If the EUT is equipped with or uses an adjustable-length antenna, then it shall be fully extended.

Supply the EUT with nominal voltage or install a new or fully charged battery in the EUT. Turn ON the EUT and couple its output to a frequency counter or other frequency measuring instrument.

NOTE An instrument that has an adequate level of accuracy as specified by the procuring or regulatory agency is the recommended measuring instrument.

b) Tune the EUT to one of the number of frequencies. Adjust the location of the measurement antenna and the controls on the measurement instrument to obtain a suitable signal level (i.e., a level that will not overload the measurement instrument but is strong enough to allow measurement of the operating or fundamental frequency of the EUT).

c) Measure the frequency at each of the frequencies.

d) Repeat the above procedure at 85% and 115% of the nominal supply voltage.

# 5.5.4 Test Data

#### PASS.

Please refer to the following pages.

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#### **Test Result:**

Test	Conditions	Frequency	Deviation	1 : 14
Power (VAC)	Temperature (Hz) (°C)		(%)	Limit
	-20	13560035	0.0003	
	-10	13560048	0.0085	
	0	13560092	0.0062	
	+10	13560014	0.0044	
120	+20	13550063	0.0089	
	+25	13560059	0.0003	+/-0.01%
	+30	13560025	0.0071	
	+40	13560091	0.0020	
	+50	13560060	0.0048	
108	+20	13560017	0.0082	
132	+20	13560045	0.0087	

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# ANNEX A TEST SETUP PHOTOS

Please refer to the document "8233EU012316W-AA.PDF"

# ANNEX B EXTERNAL PHOTOS

Please refer to the document "8233EU012316W-AB.PDF"

# ANNEX C INTERNAL PHOTOS

Please refer to the document "8233EU012316W-AC.PDF"



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# Statement

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2. The report without China inspection body and laboratory Mandatory Approval (CMA) mark has no effect of proving to the society.

3. For the report with CNAS mark or A2LA mark, the items marked with "☆" are not within the accredited scope.

4. This report is invalid if it is altered, without the signature of the testing and approval personnel, or without the "inspection and testing dedicated stamp" or test report stamp.

5. The test data and results are only valid for the tested samples provided by the customer.

6. This report shall not be partially reproduced without the written permission of the laboratory.

7. Any objection shall be raised to the laboratory within 30 days after receiving the report.

--- End of Report ---

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